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## OPEN ACCESS

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**Protocol status:** Working We use this protocol and it's working

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## Photolithography for microfluidics

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#### **ABSTRACT**

Photolithography for microfluidic mold fabrication, successfully tested at the Scottish Microelectronics Centre. Produces rounded flow layer using positive resist SPR 220-7 with ~12um features, and rectangular control layer using negative resist SU-8-3035 with ~35um features).

Adapted from <u>dx.doi.org/10.17504/protocols.io.46wgzfe</u> / Laohakunakorn et al. 2021 (<u>https://doi.org/10.1007/978-1-0716-1032-9\_9</u>).

#### **MATERIALS**

Masks: from Compugraphics. Master-Si, NFR5009, grade 2160A2.

1X Master, Soda Lime, 5"x5"x0.09" Minimum critical feature: 2.0um

Defect density: 1 per in^2 (0.2 per cm^2)

Registration: SPC CD tolerance: 0.25um Defect size: 2um Data design: rectilinear

Write area: 1" smaller than mask size

Compugraphics product code: 2160A2

#### Flow layer (SPR220, positive resist)

Digitised data = Dark

Data parity chrome up = **Wrong**Title parity chrome up = **Wrong** 

CD size = SPC Data top cell = TOP Data format = CIF

Data window = Compugraphics default

#### Control layer (SU8, negative resist)

Digitised data = Clear

Data parity chrome up = **Wrong**Title parity chrome up = **Wrong** 

CD size = SPC Data top cell = TOP Data format = CIF

Data window = Compugraphics default

#### Double-check these settings very carefully!

• Wafer properties: from Inseto.

Diameter: 100mm

Material: Si Type: N

Orientation: 100 Dopant: P-doped Grade: Test?

Lower resistivity: 1 ohm.cm Upper resistivity: 10 ohm.cm

Thickness: 525 um

Polish: SSP

## Flow Layer

- 1 **HMDS** priming
- 1.1 Prime a clean Si wafer in a sealed box with HMDS for 00:10:00

2 **Prebake** 

Transfer to hotplate and carry out pre-bake at \$\ \bigs\_{120 \circ}\$ for \$\ \colon \) 00:12:00 2.1



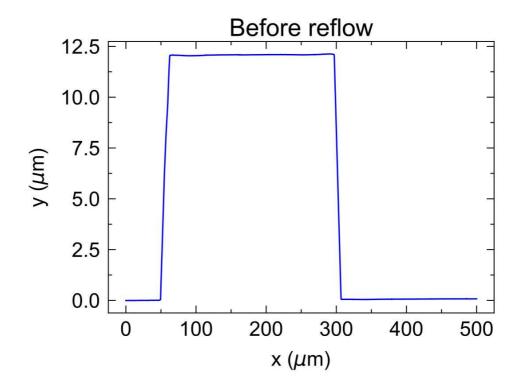
12m

10m

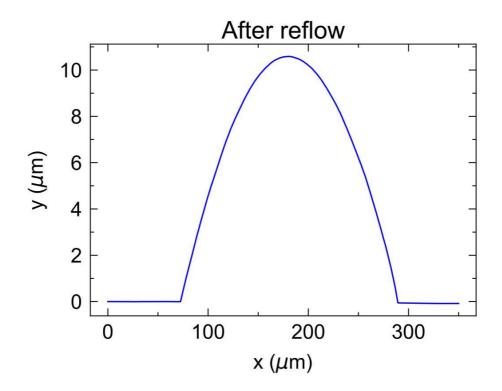
3	Spin coat with SPR 220-7 (Megaposit) SPR_220_DATA_SHEET_RH.pdf	
3.1	Transfer wafer to spin coater and run following programme using SPR 220-7 resist:  1. 400 rpm, 00:00:30  2. 1000 rpm, 00:01:40 at 200 rpm/s. This coats the wafer with ~12 um.	2m 10s
4	Softbake	
4.1	Transfer to hotplate and carry out soft-bake at promptly when done.	6m
5	Exposure	
5.1	Expose with the following settings (for a Karl Suss MA8 mask aligner):  Multiple exposure steps: [	1m 30s
	WEC=cont Expose type = prox 40um alignment gap 5um expose gap WEC offset OFF N2 purge NO	
	The Karl Suss machine has a flux of 3.99 mW/cm^2 as measured from last maintenance. We would like an exposure of 660 mJ/cm^2.	
5.2	Wait: leave the wafer in a sealed wafer box for 02:00:00	2h

# 6 Post-exposure bake 6.1 Transfer to a hotplate and hold at \$\ 110 \cdot \Color \for \cdot \O 00:05:00 5m 6.2 Wait: leave the wafer in a sealed wafer box for 00:45:00 45m 7 **Develop with MF26A** 7.1 Develop right side up for up to $\bigcirc$ 00:05:00 , rinse with DI water, and dry gently with 5m compressed N2. 8 **Reflow**

Place the wafer on a hotplate at room temperature, then ramp up to 170 °C (at a ramp rate of ~0.5\*C/s). Hold at 170 °C for 00:40:00 , then turn off hotplate and allow to ramp down to room temperature (takes a few hours).



Before reflow



After reflow

## **Control layer**

- 9 02 plasma treatment
- **9.1** Treat with 02 plasma for 10 minutes in barrel asher. (At SMC, Electrotech 508 with typical parameters: forward power 350W, flow 32%, pressure 0.8 torr)
- Spin coat with SU-8-3035 (Kayaku) MKAM-SU-8-3000-Datasheet-7.10-final.pdf
- 10.1 Spin coat with SU8-3035 using the following programme with ramp rate of 100rpm/s for all steps:

1m <u>51s</u>

- 1. **3** 500 rpm, 00:00:10
- 2. 3000 rpm, 00:01:05 = 25s ramp + 40s hold
- 3. 🚯 4000 rpm, 00:00:01
- 3. 3000 rpm, 00:00:05

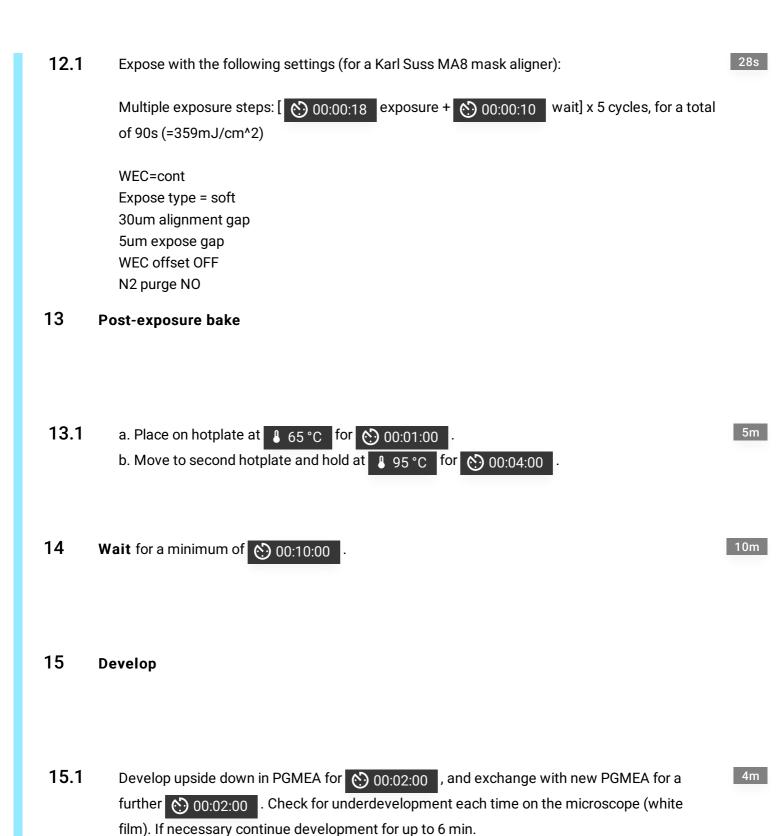
Make sure the spin coater has a plastic liner installed. If necessary clean back and edge of wafer with wipe soaked in PGMEA.

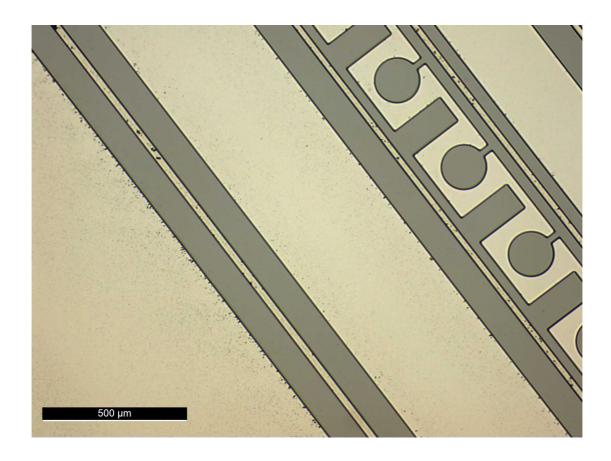
- 11 Softbake
- Place on hotplate for 00:12:30 at 95 °C

12m 30s

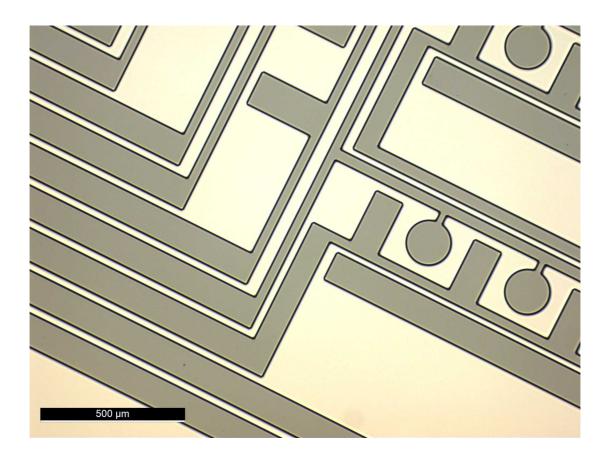
Let wafer come to room temp (few mins) before exposure. If there are wrinkles, place on hotplate until wrinkles disappear.

12 Exposure





Underdevelopment after 2+1 min



Correct development after 2+2 min

- 15.2 Rinse with IPA and dry gently with compressed air.
- 16 Hardbake
- **16.1** Ramp to \$\mathbb{1}\$ 135 °C , and hold at \$\mathbb{1}\$ 135 °C for \$\mathbb{O}\$ 02:00:00 .

2h

### Silanization of wafers

Silanization must be carried out before first use, to prevent PDMS sticking to wafers. Leave  $\Delta$  500  $\mu$ L of chlorotrimethylsilane (Sigma 386529) in an upturned Falcon cap, inside a sealed box with the wafers until the solvent has completely evaporated.